## Abstract of the Disclosure

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The object of the invention is to provide technique and an apparatus for precisely measuring high frequency current that flows in a transmission line of a small impedance load circuit. A current waveform can be measured in wide bandwidth (at high-time resolution) and at high sensitivity without processing DUT (nondestructive) and without having an effect of the impedance of the apparatus (noninvasive) by installing a magnetooptical device in a magnetic field generated based upon current that flows in the transmission line, applying a bias magnetic field to the magnetooptical device by a magnetic field generator, making polarized light incident under the control of a position so that detection sensitivity is maximum and detecting the variation of polarization included in reflected light from the magnetooptical device.